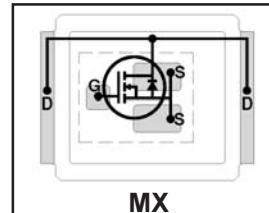


# IRF6620PbF

## IRF6620TRPbF

DirectFET™ Power MOSFET ②

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>Q<sub>g(typ.)</sub></b>
20V	2.7mΩ@V <sub>GS</sub> = 10V	28nC
	3.6mΩ@V <sub>GS</sub> = 4.5V	



- RoHS Compliant ①
- Lead-Free (Qualified up to 260°C Reflow)
- Application Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- High CdV/dt Immunity
- Low Profile (<0.7mm)
- Dual Sided Cooling Compatible ①
- Compatible with existing Surface Mount Techniques ①

Applicable DirectFET Outline and Substrate Outline (see p.8,9 for details)

SQ	SX	ST		MQ	MX	MT				
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### Description

The IRF6620PbF combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance in a package that has the footprint of an SO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

The IRF6620PbF balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF6620PbF has been optimized for parameters that are critical in synchronous buck operating from 12 volt bus converters including Rds(on), gate charge and CdV/dt-induced turn on immunity. The IRF6620PbF offers particularly low Rds(on) and high CdV/dt immunity for synchronous FET applications.

### Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	20	V
V <sub>GS</sub>	Gate-to-Source Voltage	±20	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑨	150	A
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑩	27	
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑪	22	
I <sub>DM</sub>	Pulsed Drain Current ⑫	220	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation ⑬	89	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Power Dissipation ⑭	1.8	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation ⑮	2.8	
E <sub>AS</sub>	Single Pulse Avalanche Energy ⑯	39	mJ
I <sub>AR</sub>	Avalanche Current ⑰	22	A
	Linear Derating Factor	0.017	W/°C
T <sub>J</sub>	Operating Junction and	-40 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>0JA</sub>	Junction-to-Ambient ⑯⑰	—	45	°C/W
R <sub>0JA</sub>	Junction-to-Ambient ⑯⑰	12.5	—	
R <sub>0JA</sub>	Junction-to-Ambient ⑯⑰	20	—	
R <sub>0JC</sub>	Junction-to-Case ⑯⑰	—	1.4	
R <sub>0J-PCB</sub>	Junction-to-PCB Mounted	1.0	—	

Notes ① through ⑯ are on page 2

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

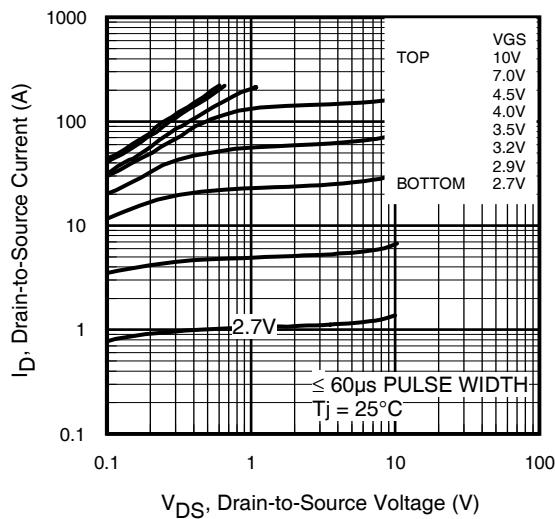
	Parameter	Min.	Typ.	Max.	Units	Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	16	—	mV/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	—	2.1	2.7	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 27\text{A}$ ⑤
		—	2.8	3.6		$V_{\text{GS}} = 4.5\text{V}$ , $I_D = 22\text{A}$ ⑤
$V_{\text{GS(th)}}$	Gate Threshold Voltage	1.55	—	2.45	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$\Delta V_{\text{GS(th)}}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-5.8	—	mV/ $^\circ\text{C}$	
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	150		$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$
$g_{\text{fs}}$	Forward Transconductance	110	—	—	S	$V_{\text{DS}} = 10\text{V}$ , $I_D = 22\text{A}$
$Q_g$	Total Gate Charge	—	28	42	nC	$V_{\text{DS}} = 10\text{V}$ $V_{\text{GS}} = 4.5\text{V}$ $I_D = 22\text{A}$ See Fig. 15
$Q_{\text{gs1}}$	Pre-Vth Gate-to-Source Charge	—	9.5	—		
$Q_{\text{gs2}}$	Post-Vth Gate-to-Source Charge	—	3.5	—		
$Q_{\text{gd}}$	Gate-to-Drain Charge	—	8.8	—		
$Q_{\text{godr}}$	Gate Charge Overdrive	—	6.2	—		
$Q_{\text{sw}}$	Switch Charge ( $Q_{\text{gs2}} + Q_{\text{gd}}$ )	—	12	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 10\text{V}$ $f = 1.0\text{MHz}$
$Q_{\text{oss}}$	Output Charge	—	16	—		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	18	—		
$t_r$	Rise Time	—	80	—		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	20	—	ns	$V_{\text{DD}} = 16\text{V}$ , $V_{\text{GS}} = 4.5\text{V}$ ⑤ $I_D = 22\text{A}$ Clamped Inductive Load
$t_f$	Fall Time	—	6.6	—		
$C_{\text{iss}}$	Input Capacitance	—	4130	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 10\text{V}$ $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	1160	—		
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	560	—		

**Diode Characteristics**

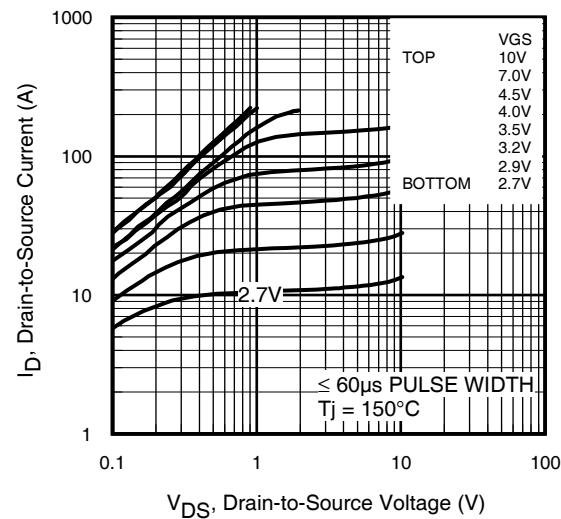
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current@ $T_C=25^\circ\text{C}$ (Body Diode)	—	—	110	A	MOSFET symbol showing the integral reverse p-n junction diode.
		—	—	220		
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ③	—	—	—		
$V_{\text{SD}}$	Diode Forward Voltage	—	0.8	1.0	V	$T_J = 25^\circ\text{C}$ , $I_S = 22\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ⑤
$t_{\text{rr}}$	Reverse Recovery Time	—	23	35	ns	$T_J = 25^\circ\text{C}$ , $I_F = 22\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	13	20	nC	$\text{di}/\text{dt} = 100\text{A}/\mu\text{s}$ ⑤

**Notes:**

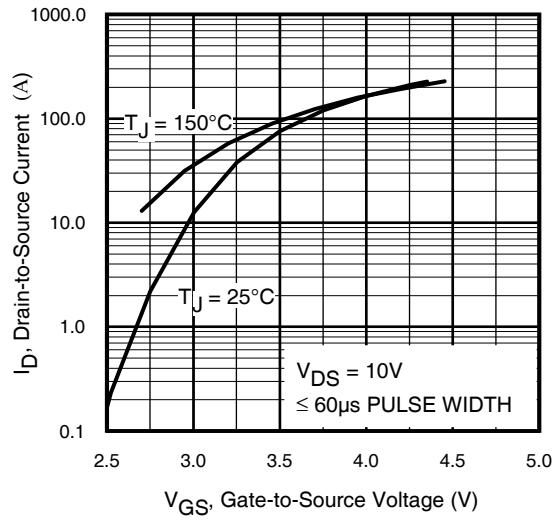
- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Repetitive rating; pulse width limited by max. junction temperature.
- ④ Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.16\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 22\text{A}$ .
- ⑤ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑥ Surface mounted on 1 in. square Cu board.
- ⑦ Used double sided cooling, mounting pad.
- ⑧ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- ⑨  $T_c$  measured with thermal couple mounted to top (Drain) of part.
- ⑩  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .



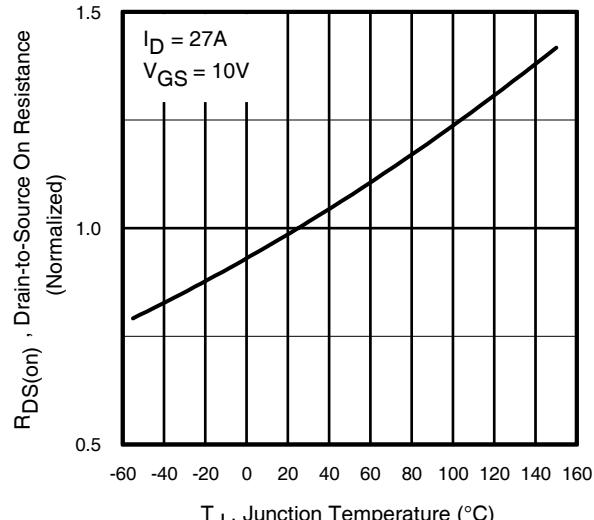
**Fig 1.** Typical Output Characteristics



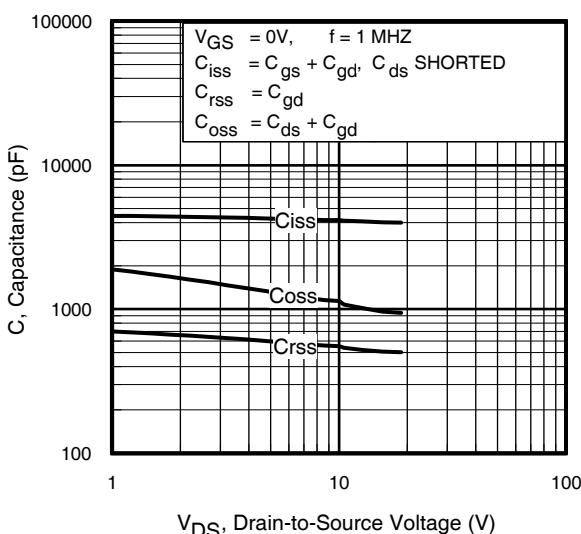
**Fig 2.** Typical Output Characteristics



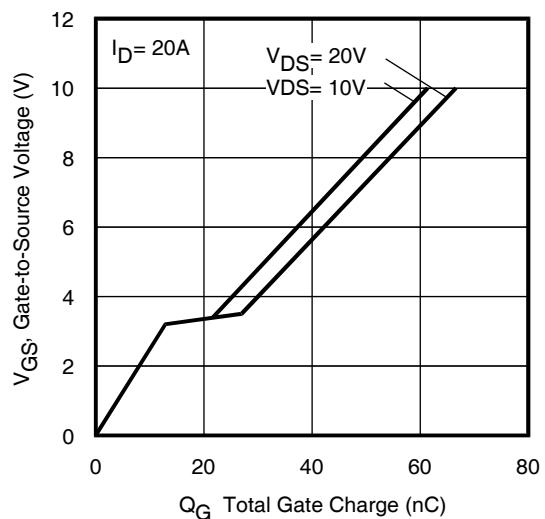
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance vs. Temperature



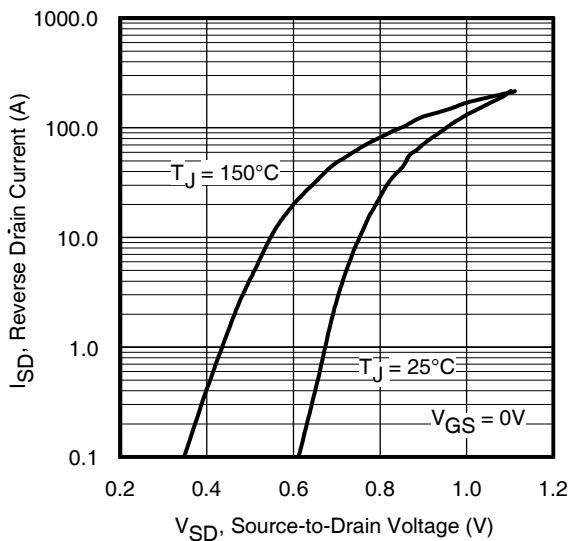
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage  
[www.irf.com](http://www.irf.com)



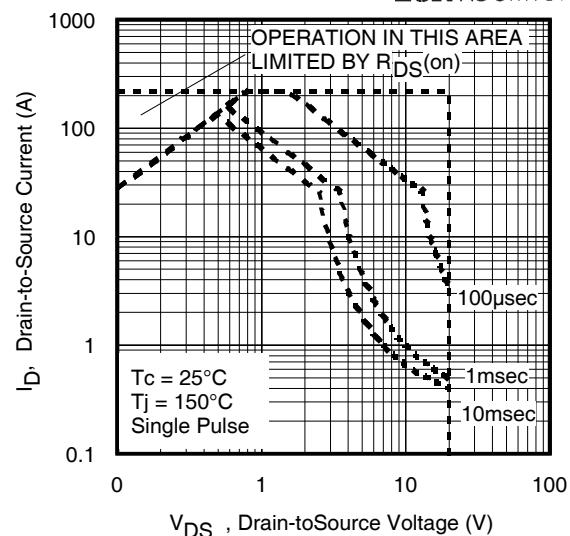
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

# IRF6620PbF

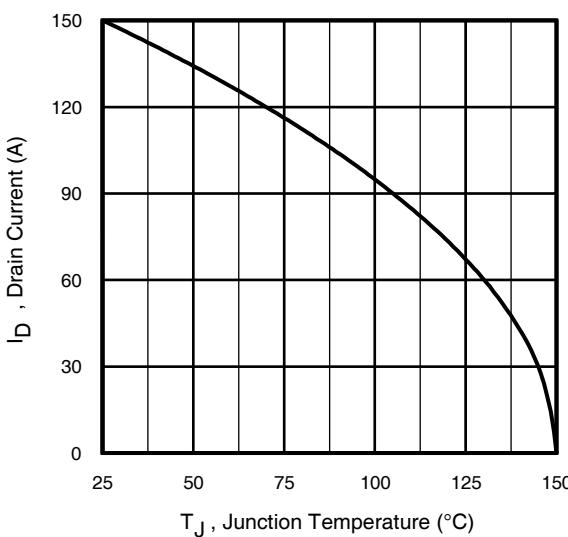
International  
Rectifier



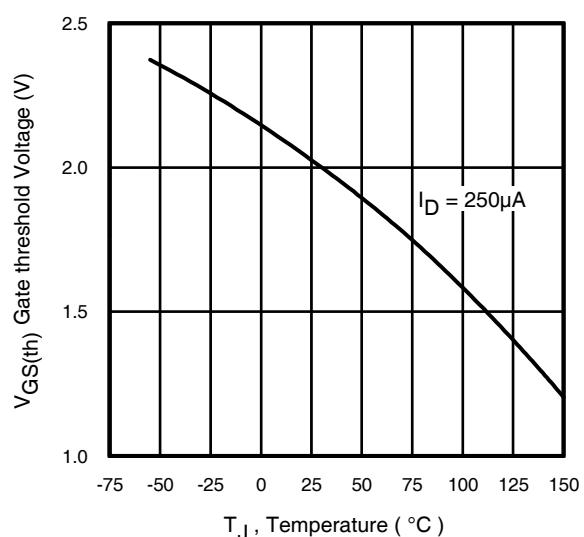
**Fig 7.** Typical Source-Drain Diode Forward Voltage



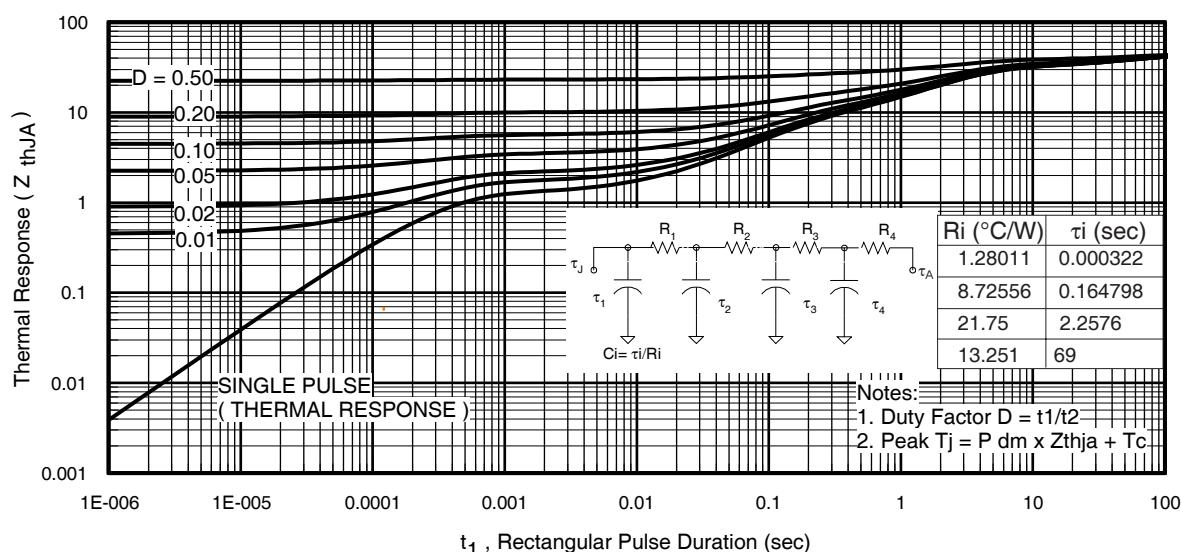
**Fig 8.** Maximum Safe Operating Area



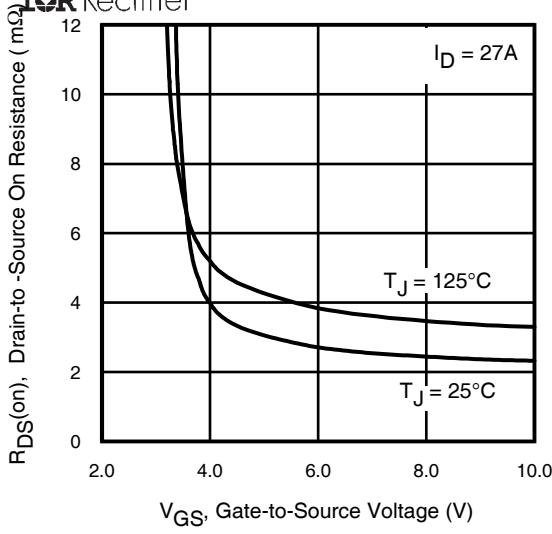
**Fig 9.** Maximum Drain Current vs. Case Temperature



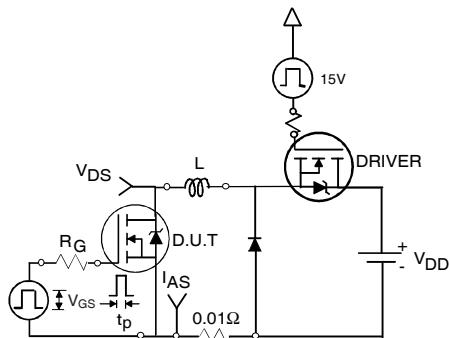
**Fig 10.** Threshold Voltage vs. Temperature



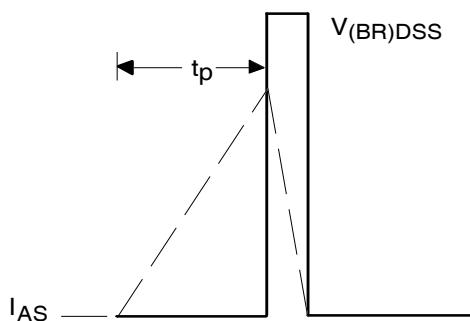
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



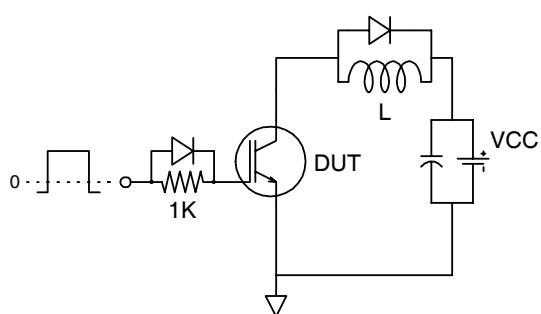
**Fig 12.** On-Resistance Vs. Gate Voltage



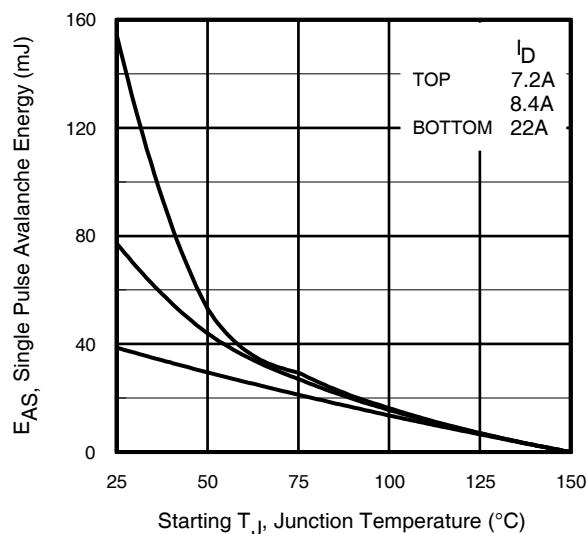
**Fig 13a.** Unclamped Inductive Test Circuit



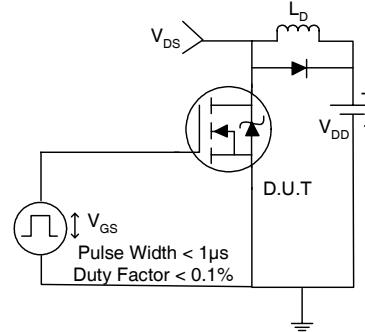
**Fig 13b.** Unclamped Inductive Waveforms



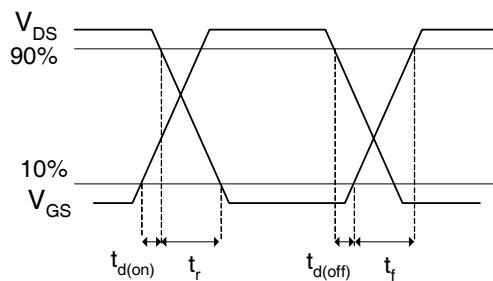
**Fig 15a.** Gate Charge Test Circuit



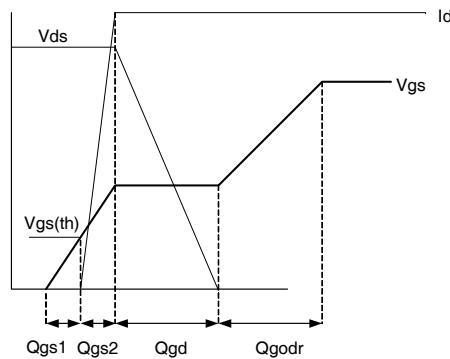
**Fig 13c.** Maximum Avalanche Energy Vs. Drain Current



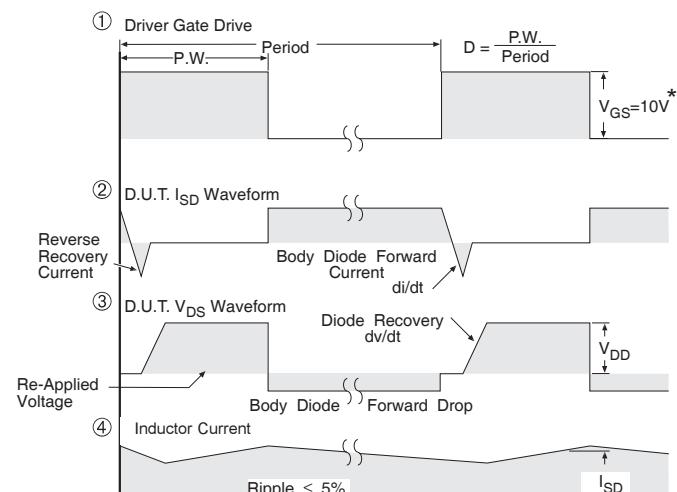
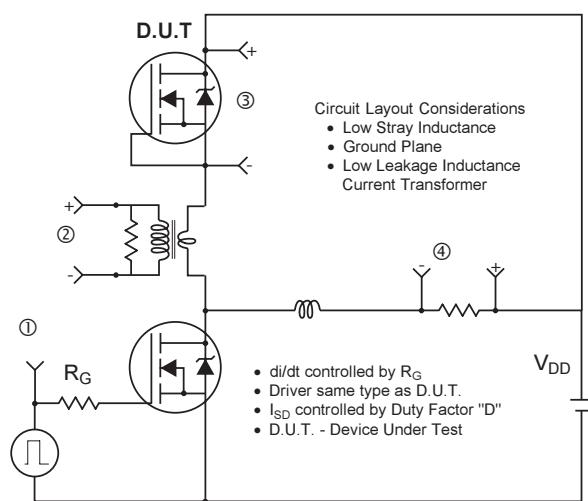
**Fig 14a.** Switching Time Test Circuit



**Fig 14b.** Switching Time Waveforms



**Fig 15b.** Gate Charge Waveform

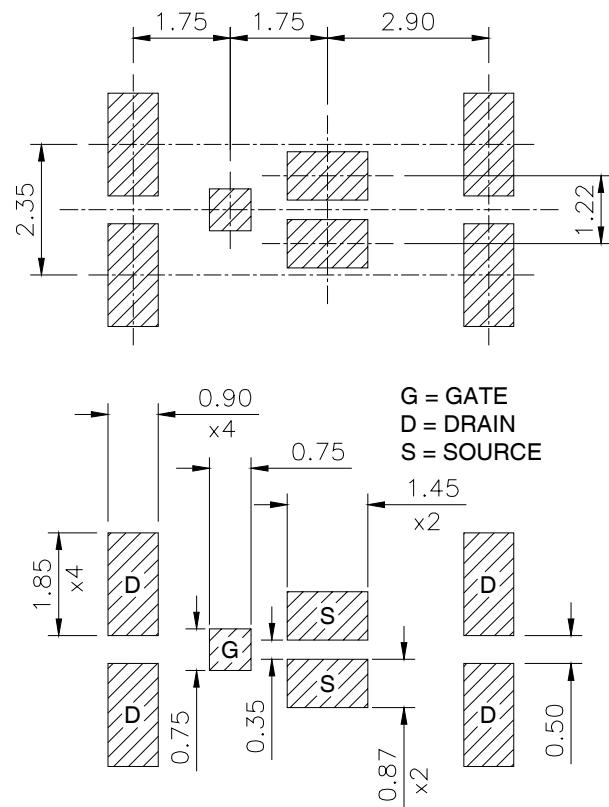


\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 16.** Diode Reverse Recovery Test Circuit for N-Channel HEXFET® Power MOSFETs

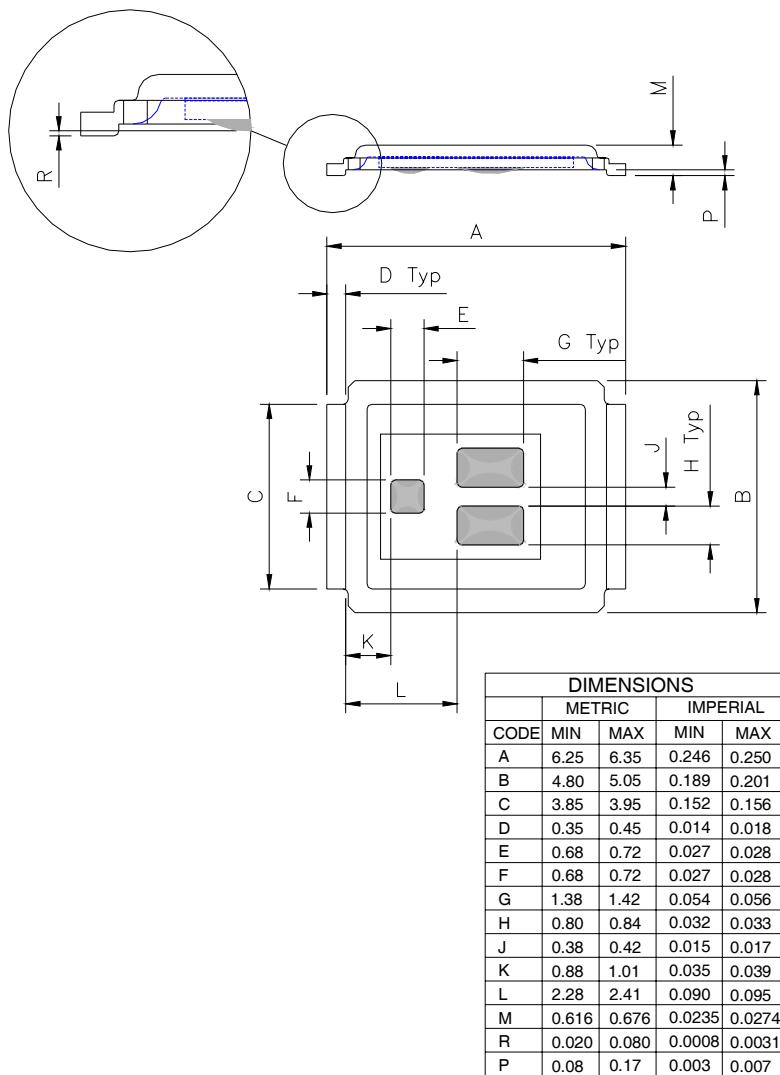
## DirectFET™ Substrate and PCB Layout, MX Outline (Medium Size Can, X-Designation).

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.

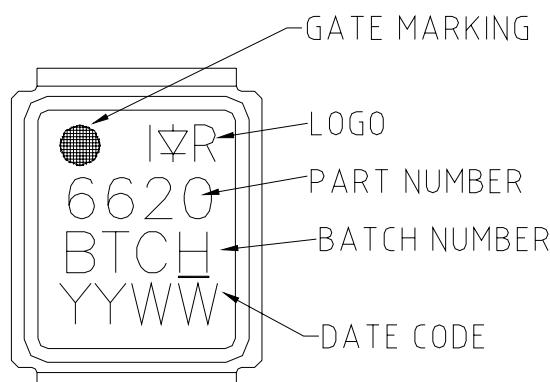


## DirectFET™ Outline Dimension, MX Outline (Medium Size Can, X-Designation).

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.



## DirectFET™ Part Marking

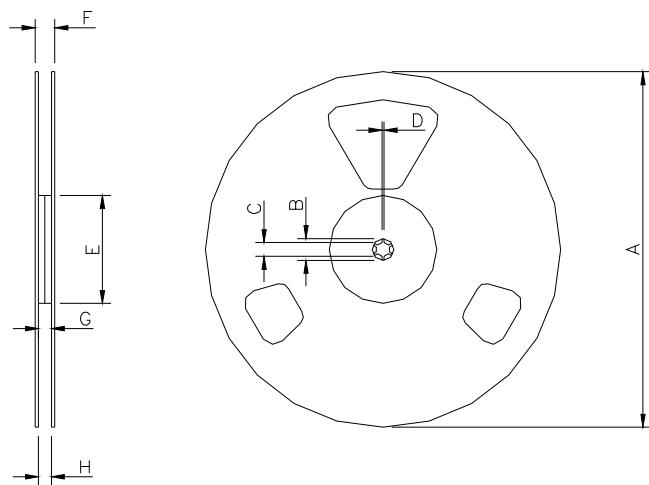


Note: Line above the last character of the date-code indicates "Lead-Free".

# IRF6620PbF

International  
**IR** Rectifier

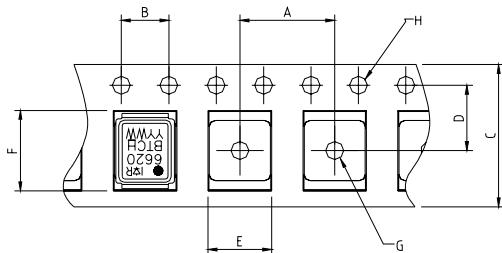
DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm  
Std reel quantity is 4800 parts. (ordered as IRF6620TRPBF). For 1000 parts on 7" reel, order IRF6620TR1PBF

REEL DIMENSIONS								
STANDARD OPTION (QTY 4800)				TR1 OPTION (QTY 1000)				
	METRIC	IMPERIAL		METRIC	IMPERIAL			
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
A	330.0	N.C.	12.992	N.C.	177.77	N.C.	6.9	N.C.
B	20.2	N.C.	0.795	N.C.	19.06	N.C.	0.75	N.C.
C	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C.	0.059	N.C.	1.5	N.C.	0.059	N.C.
E	100.0	N.C.	3.937	N.C.	58.72	N.C.	2.31	N.C.
F	N.C.	18.4	N.C.	0.724	N.C.	13.50	N.C.	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C.
H	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C.

LOADED TAPE FEED DIRECTION



DIMENSIONS								
	METRIC	IMPERIAL			METRIC	IMPERIAL		
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319				
B	3.90	4.10	0.154	0.161				
C	11.90	12.30	0.469	0.484				
D	5.45	5.55	0.215	0.219				
E	5.10	5.30	0.201	0.209				
F	6.50	6.70	0.256	0.264				
G	1.50	N.C.	0.059	N.C.				
H	1.50	1.60	0.059	0.063				

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
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Note: For the most current drawings please refer to the IR website at:  
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[FF300R06KE3HOSA1](#) [FF600R12ME4P](#) [FF600R17ME4\\_B11](#) [FP25R12KT4\\_B11](#) [FS150R12KE3G](#) [FS600R07A2E3\\_B31](#)  
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[E6327](#) [BCR 141S H6327](#) [BCR 141W H6327](#) [BCR 162 E6327](#) [BCR 183W H6327](#) [BCR 185S H6327](#) [BCR 192 E6327](#) [BCR 198 E6327](#) [BCR 35PN H6327](#) [BCR 523U E6327](#)